

STP40NF10

N-channel 100 V, 0.025 Ω, 50 A TO-220 low gate charge STripFET™ II Power MOSFET

Features

Order code	V _{DSS}	R _{DS(on)} max.	I _D
STP40NF10	100 V	< 0.028 Ω	50 A

- Exceptional dv/dt capability
- Low gate charge
- 100% avalanche tested

Application

Switching applications

Description

This N-channel 100 V Power MOSFET is the latest development of STMicroelectronics unique "single feature size" strip-based process. The resulting transistor shows extremely high packing density for low on-resistance, rugged avalanche characteristics and less critical alignment steps allowing remarkable manufacturing reproducibility.

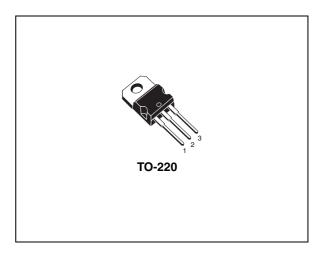


Figure 1. Internal schematic diagram

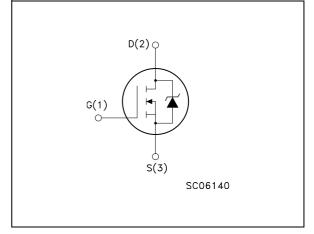


Table 1. Device summary

Order code	Marking	Package	Packaging
STP40NF10	P40NF10@	TO-220	Tube

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Electrical ratings

Table 2. Absolute maximum rating	Table 2.	Absolute maximum ratin	qs
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Symbol	Parameter	Value	Unit
V _{DS}	Drain-source voltage (V _{GS} = 0)	100	V
V _{GS}	Gate- source voltage	±20	V
I _D ⁽¹⁾	Drain current (continuous) at $T_{C} = 25 \ ^{\circ}C$	50	Α
I _D	Drain current (continuous) at T _C = 100 °C	35	Α
I _{DM} ⁽²⁾	Drain current (pulsed)	200	Α
P _{TOT}	Total dissipation at T _C = 25 °C	150	W
	Derating factor	1	W/°C
dv/dt ⁽³⁾	Peak diode recovery voltage slope	27	V/ns
E _{AS} ⁽⁴⁾	Single pulse avalanche energy	385	mJ
T _{stg}	Storage temperature	55 to 175	°C
Тj	Max. operating junction temperature	- 55 10 175	

1. Limited by wire bonding

2. Pulse width limited by safe operating area

3. $I_{SD} \leq 50$ A, di/dt ≤ 600 A/µs, $V_{DD} \leq V_{(BR)DSS}$, $T_j \leq T_{JMAX.}$

4. Starting T_j = 25 °C, I_D = 50 A, V_{DD} =25 V

Symbol	Parameter	Value	Unit
R _{thj-case}	Thermal resistance junction-case max	1	°C/W
R _{thj-a}	Thermal resistance junction-ambient max	62.5	°C/W
Τ _Ι	Maximum lead temperature for soldering purpose	300	°C



2 Electrical characteristics

(T_{CASE} = 25 °C unless otherwise specified)

	On/on states					
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source Breakdown voltage	$I_{D} = 250 \ \mu A, \ V_{GS} = 0$	100			V
	Zero gate voltage	V _{DS} = Max rating			1	μA
I _{DSS}	Drain current (V _{GS} = 0)	V_{DS} =Max rating, T_{C} =125°C			10	μA
I _{GSS}	Gate-body leakage current (V _{DS} = 0)	$V_{GS} = \pm 20 V$			±100	nA
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 250 \ \mu A$	2	3	4	V
R _{DS(on)}	Static drain-source on resistance	V_{GS} = 10 V, I _D = 25 A		0.025	0.028	Ω

Table 4. On/off states

Table 5. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
9 _{fs} ⁽¹⁾	Forward transconductance	$V_{DS} = 15 V_{,} I_{D} = 28 A$	-	22		S
C _{iss}	Input capacitance			2180		pF
C _{oss}	Output capacitance	V _{DS} = 25 V, f = 1 MHz, V _{GS} = 0	-	298		pF
C _{rss}	Reverse transfer capacitance	V _{GS} = 0		83.7		pF
Qg	Total gate charge	V _{DD} = 50 V, I _D = 40 A,		46.5	62	nC
Q _{gs}	Gate-source charge	V _{GS} = 10V	-	13.3		nC
Q _{gd}	Gate-drain charge	(see Figure 15)		17.5	22.5	nC

1. Pulsed: Pulse duration = $300 \ \mu$ s, duty cycle 1.5.

Table 6. Switching ti

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)} t _r	Turn-on delay time Rise time	$V_{DD} = 50V, I_D = 25A$ $R_G = 4.7\Omega V_{GS} = 10V$	-	21 46	-	ns ns
t _{d(off)} t _f	Turn-off-delay time Fall time	(see Figure 14)	-	54 13	-	ns ns



Symbol	Parameter	Test conditions	Min.	Тур.	Max	Unit
I _{SD}	Source-drain current		-		80	А
$I_{SDM}^{(1)}$	Source-drain current (pulsed)		-		320	А
V _{SD} ⁽²⁾	Forward on voltage	$I_{SD} = 50A, V_{GS} = 0$	-		1.5	V
t _{rr} Q _{rr} I _{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	$I_{SD} = 50A, V_{DD} = 25V$ di/dt = 100A/µs, T _j = 150°C (see Figure 16)	-	80 250 6.4		ns nC A

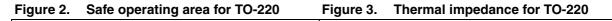
Table 7.Source drain diode

1. Pulse width limited by safe operating area.

2. Pulsed: Pulse duration = 300 μ s, duty cycle 1.5%



2.1 Electrical characteristics (curves)

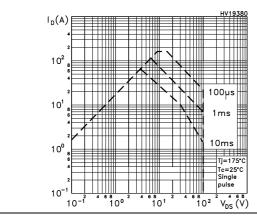


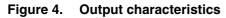
κ

10

10⁻²

 $\delta = 0.5$





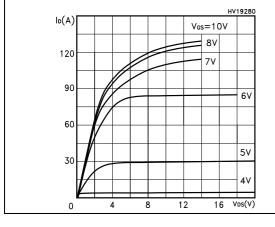


Figure 6. Transconductance



10-4

1111

0.05 0.02

10-3

10-2

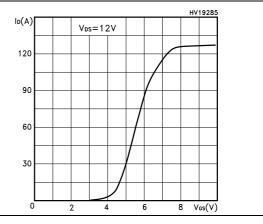
0.02

SINGLE PULSE

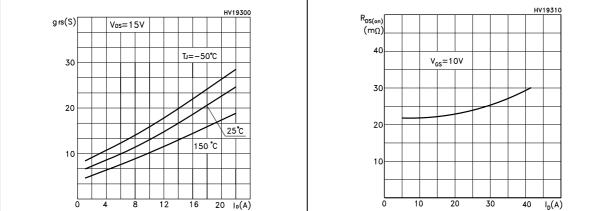
 $Z_{th} = k R_{thJ-c}$

10⁻¹ † P (s)

 $\delta=\,{\rm t_p}\,/\tau$









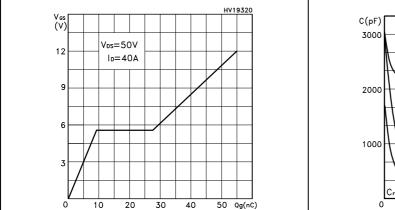


Figure 8. Gate charge vs. gate-source voltage Figure 9. Capacitance variations

Figure 10. Normalized gate threshold voltage vs. temperature

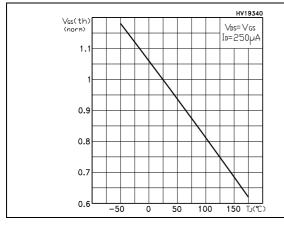


Figure 12. Source-drain diode forward characteristics

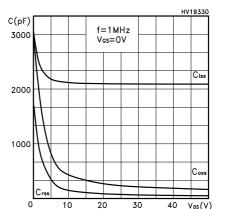


Figure 11. Normalized on resistance vs. temperature

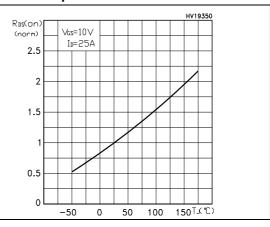
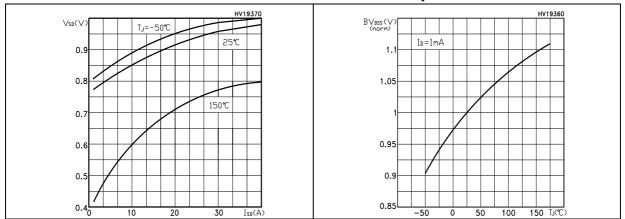


Figure 13. Normalized breakdown voltage vs. Tj





3 Test circuit

Figure 14. Switching times test circuit for resistive load

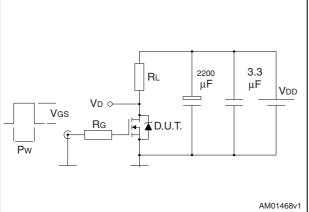
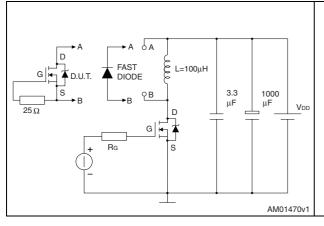
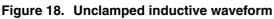


Figure 16. Test circuit for inductive load switching and diode recovery times





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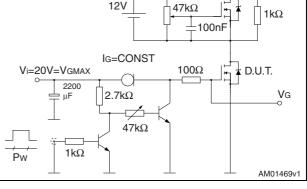
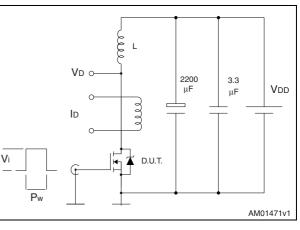


Figure 15. Gate charge test circuit

Figure 17. Unclamped Inductive load test circuit



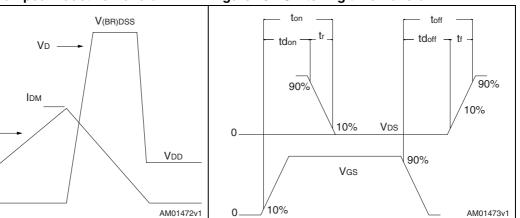


Figure 19. Switching time waveform

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Vdd

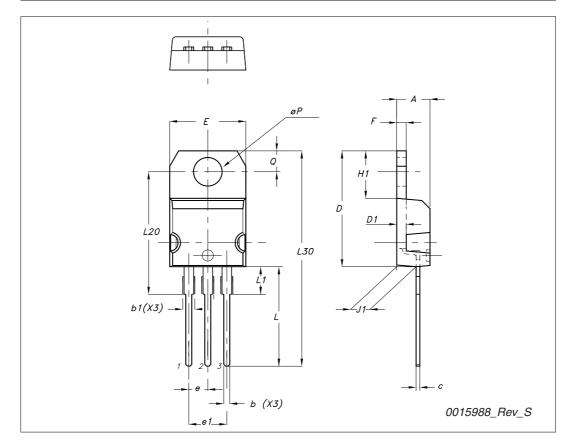
4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK[®] packages, depending on their level of environmental compliance. ECOPACK[®] specifications, grade definitions and product status are available at: www.st.com. ECOPACK is an ST trademark.



Dim	mm		
	Min	Тур	Max
Α	4.40		4.60
b	0.61		0.88
b1	1.14		1.70
С	0.48		0.70
D	15.25		15.75
D1		1.27	
E	10		10.40
e e1	2.40		2.70
	4.95		5.15
F	1.23		1.32
H1	6.20		6.60
J1	2.40		2.72
L	13		14
L1	3.50		3.93
L20		16.40	
L30		28.90	
ØP	3.75		3.85
Q	2.65		2.95





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5 Revision history

Table 8.Document revision history

Date	Revision	Changes
16-Dec-2004	1	First version.
17-Aug-2006	2	The document has been reformatted.
31-Jan-2007	3	Typo mistake on <i>Table 2</i> .
19-Sep-2007	4	Added DPAK.
10-Nov-2010	5	Removed DPAK.



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